NOTES:

- 1. SUBSTRATE FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL TO SURFACE S1 TO WITHIN <3 ARCMIN
- 3. COATING (APPLY ACROSS COATING APERTURE):

S1: 532 HR Coating R (ABS) > 99.80% @ 532nm @ 45° AOI R (AVG) > 99.5% @ 523 - 537nm @ 45° AOI

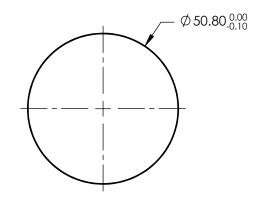
DAMAGE THRESHOLD, PULSED: 15 J/cm², 20ns, 20Hz @ 532nm CW: 1MW/cm² @ 532nm

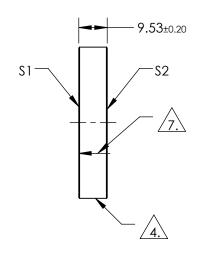
S2: NONE

4. FINE GRIND SURFACE

- POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACES

APPLY ARROW ON EDGE WITH LASER ETCH, PENCIL, OR PERMANENT INK POINTING TOWARDS SURFACE S1





FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	\$1	S2		ĺ		(A)
SHAPE	PLANO	PLANO				Edmund Optics®
SURFACE QUALITY	10-5	COMMERCIAL POLISH				
SURFACE FLATNESS	0.10 WAVE	N/A		_		Ø50.8mm x 9.53mm,532nm, NdYAG MIRROR
MIN CLEAR APERTURE	Ø40.64	N/A	THIRD ANGLE PROJECTION		TITLE	45° AOI
MIN COATING APERTURE	Ø45.72	N/A		1		
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	38889 SHEET 1 OF 1